## nexperia

## **Quarterly Reliability Monitoring Results**

Quarters: Q1/2022 to Q4/2023 Based on structural similarity

| Supplier   |  | User Part Number   |                                   |           |            |           |
|--|--|--|-----------------------------------|-----------|------------|-----------|
| Nexperia B.V.<br>Name of Laboratory<br>Assembly reliability labs<br>Based on AEC-Q101 Test |  | BZX84-B6V8-Q Part Description  |                                   |           |            |           |
|  |  |  |                                   |           |            |           |
|  |  | SMD package  |                                   |           |            |           |
|  |  | Test Conditions  | Duration                          | # Lots    | # Quantity | # Rejects |
|  |  |  | TEST<br>Pre- and Post-Stress      |           |            |           |
| # E1   | Electrical Test  | Tamb = 25 °C   | N/A                               | see below | all parts  | see below |
| # A1   | <b>PC</b><br>Preconditioning                                   | JESD22-A113<br>Bake Tamb = 125 °C<br>Soak Tamb = 85 °C, RH = 85%<br>Reflow soldering                   | 24 hours<br>168 hours<br>3 cycles | 1514      | 64430      | 0         |
| # B1   | HTRB<br>High Temperature Reverse<br>Bias                       | MIL-STD-750-1<br>M1038 Method A<br>Tj = Tjmax, VR = 80 % of rated reverse<br>voltage                   | 1000 hours                        | 250       | 11400      | 0         |
| # B1b  | SSOP<br>Steady State Operational                               | MIL-STD-750-1<br>M1038 Method B<br>Tj = Tjmax, Iz = 100% of max. datasheet<br>reverse current          | 1000 hours                        | 44        | 1920       | 0         |
| # A4   | <b>TC</b><br>Temperature Cycling                               | JESD22-A104<br>-65 °C to Tjmax, not to exceed 150°C  | 1000 cycles                       | 311       | 14080      | 0         |
| # A3 <b>or</b>   | <b>UHAST</b><br>Unbiased HAST                                  | JESD22-A118<br>Tamb = 130 °C, RH = 85 %  | —96 hours                         | 311       | 14080      | 0         |
| # A3 alt   | <b>AC</b><br>Autoclave   | JESD22-A102<br>Tamb = 121 °C, RH = 100 %<br>Pressure = 205 kPa (29.7 psia)                             |                                   |           |            |           |
| # A2 alt   | <b>H3TRB</b><br>High Humidity High<br>Temperature Reverse Bias | JESD22-A101<br>Tamb = 85 °C, RH = 85%, VR = 80 % of<br>rated reverse voltage <sup>[1]</sup>            | 1000 hours                        | 311       | 14080      | 0         |
| # A5   | <b>IOL</b><br>Intermittent Operating Life                      | MIL-STD-750 Method 1037<br>ton = toff, devices powered to insure $\Delta Tj$ = 100 °C for 15000 cycles | 1000 hours                        | 312       | 14120      | 0         |
|  | RSH  | JESD22-A111  | 1000 10015                        | 012       | 1.120      |           |
| # C8   |  | 260 °C ± 5 °C  | 10 s                              | 269       | 8070       | 0         |
| # C10  | <b>SD</b><br>Solderability                                     | J-STD-002  |                                   | 19        | 6660       | 0         |
| 010  |  | · · · · · ·  |                                   |           |            | -         |

[1] The maximum applied voltage is limited by test chamber set up and does not exceed 115V.

## Calculation of FIT and MTTF

Test considered for FIT calculation: High Temperature Reverse Bias (HTRB, Test #B1) Confidence level 60%, derated to 55 °C, activation energy 0.7 eV, test time 168 to 1000 hours

| 2,68E+09 |
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